

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10599609	OOHASHI ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	SELIM AHMED	2826

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
257	292,	12/12/08	/sa/
	Updated search	6/22/2009	/sa/

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Text search such as, (photo or light)/detector, diode, sensor, amplifier, optical fiber, coupler, case/package, scatter, metal, semiconductor, impurity/doping, aperture/opening/hole and their boolean combinations were searched.	12/12/08	/sa/
Updated search	6/22/2009	/sa/

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

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